

Raman Studies of Semiconducting Oxide Nanobelts

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Crystalline nanobelts of ZnO and SnO₂ were prepared from a thermal evaporation of oxide powders inside an alumina tube in the absence of catalysts. Typical dimensions of the nanobelt samples ranged from ~10 to 100 μm in length, 30 to 300 nm in width, and 6 to 30 nm in thickness. Room temperature Raman spectra were obtained on pressed mats of nanobelt samples and compared with the corresponding spectra of the starting oxide powders and bulk materials. Collectively, our Raman data indicated that the as-prepared nanobelt samples used in this study were oxygen deficient. Upon annealing at 900 °C in flowing oxygen for 1 h, the nanobelt samples exhibited Raman features that corresponded to those expected in respective bulk semiconducting oxides. The dimensions of the nanobelts were a bit too large to expect significant quantum size effects on the phonon structure similar to those observed in carbon nanotubes and short-period semiconductor superlattices.

Keywords: Nanobelts, ZnO, SnO₂, Raman Spectroscopy.

1. INTRODUCTION

Continued interest in the synthesis and properties of nanoscale materials such as nanotubes and nanowires has led to the recent discovery of semiconducting oxide nanobelts.¹ Ultralong belt-like nanostructures of zinc, tin, indium, cadmium, and gallium semiconducting oxides were recently prepared by evaporation of commercial metal oxides at high temperatures.¹ Bulk crystalline SnO₂ and SnO₂ nanoparticles are currently being used as transparent electrodes² and in gas-sensing applications.³ ZnO films and nanoparticles have found many applications, such as transparent conductive films, solar cell windows, and photocatalysis, as well as being a potential candidate for photonic devices in the ultraviolet range.⁴ These semiconducting oxides in nanostructured forms offer new areas of fundamental research and applications. For example, ultraviolet lasing in ZnO nanowire arrays in which the nanowire diameters range between 20 and 150 nm has been recently demonstrated.⁵ In this paper, we focus on the Raman scattering properties of SnO₂ and ZnO nanobelts with typical widths of 30–300 nm, width-to-thickness ratios of 5–10, and lengths of up to a few millimeters. The width dimension of the nanobelts is in the regime where the quantum confinement phenomenon may occur.

2. EXPERIMENTAL DETAILS

2.1. Synthesis

A detailed description of SnO₂ and ZnO nanobelt synthesis can be found in Ref. 1. Briefly, nanobelt synthesis is based on the thermal evaporation of oxide powders in an alumina tube under controlled conditions without catalyst material.¹ The typical evaporation time was ~2 h, the alumina tube pressure was ~300 torr, and the argon flow rate was ~50 sccm. The nanobelts were deposited at the end of the tube on aluminum substrates. XRD confirmed that the SnO₂ nanobelts have a rutile structure, the same as bulk crystalline SnO₂, with lattice constants of $a = 4.722 \text{ \AA}$ and $c = 3.184 \text{ \AA}$.¹ A similar analysis was performed on the ZnO nanobelts, which were identified to have a wurtzite structure (like that in bulk ZnO) with lattice constants $a = 3.249 \text{ \AA}$ and $c = 5.206 \text{ \AA}$. Moreover, high-resolution transmission electron microscopy confirmed that the nanobelts were crystalline and dislocation free.¹

2.2. Raman Spectroscopy

Room-temperature Raman spectra were collected from pressed mats of SnO₂ and ZnO nanobelt samples with excitation wavelengths from a Spectra Physics Stabilite 2017 argon ion laser (488 and 514.5 nm) and a Spectra Physics 2080 Krypton ion laser (647.1 nm). With a series of lenses, the beam was focused to a 0.1 mm × 3 mm

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strip image on the sample. All Raman data were collected in a back-scattering geometry with a Kaiser Optics holographic notch filter employed for the rejection of Rayleigh scattered light from the sample. A SPEX Triax 550 single-grating spectrometer with a liquid nitrogen-cooled CCD detector was used for the collection of the Raman spectra.

3. RESULTS AND DISCUSSION

The Raman spectra for the SnO₂ nanobelts with the 488-, 514.5-, and 647.1-nm excitation wavelengths are shown in the top panel of Figure 1. For comparison, Raman spectra were also obtained from the starting powder materials used in the nanobelt synthesis. For all three excitation wavelengths, two peaks at ~ 112 cm⁻¹ and ~ 210 cm⁻¹ were observed in the Raman spectra for the starting powders, confirming its stoichiometric composition as SnO. As an example, the bottom panel of Figure 1 shows the spectrum of the starting powders excited with 488 nm. All other features are broad and/or at least one order of magnitude weaker compared with the 112 cm⁻¹ and 210 cm⁻¹ peaks, suggesting that the two strong Raman peaks correspond to SnO, not SnO₂. In bulk SnO₂, four Raman active modes are expected at 123 cm⁻¹ (B_{1g}), 476 cm⁻¹ (E_g), 634 cm⁻¹ (A_{1g}), and 778 cm⁻¹ (B_{2g}).^{6–8} The B_{1g} phonon corresponds to a librational motion of octahedra.⁶ It was first detected by Percy and Morosin⁷ in single crystalline SnO₂, but its Raman intensity is so weak that it is not commonly observed. There is no discernible B_{1g} peak in any of the spectra in Figure 1. With magnification of the spectra in Figure 1 by 20 \times , peaks visible at 476 cm⁻¹ and 627 cm⁻¹ can be assigned to the E_g and A_{1g} peaks expected for SnO₂. Upon further magnification (200 \times), a weak shoulder is observed in the vicinity of 776 cm⁻¹, which could be assigned to the B_{2g} mode in SnO₂ (not shown in Fig. 1). Furthermore, Raman

peaks corresponding to SnO are weakly present in the nanobelt spectra in Figure 1.

The two dominant peaks seen in the nanobelt spectra in Figure 1 are present at ~ 145 cm⁻¹ and ~ 171 cm⁻¹. Sangaletti et al.⁹ have carried out Raman studies involving oxidation of Sn films on alumina substrates that were systematically heat-treated in air for 5 h from 250 °C to 650 °C in intervals of 100 °C. After each annealing step, Raman and X-ray diffraction data were obtained to correlate Raman spectral changes with corresponding stoichiometric composition of their films. Two new Raman peaks appeared at 145 cm⁻¹ and 171 cm⁻¹ and were identified with a stoichiometric SnO_x phase ($1 < x < 2$).⁹ Known phases with this intermediate degree of oxidation are Sn₂O₃ and Sn₃O₄.^{10,11} In a similar but independent study, Geurts et al.¹² annealed SnO films grown on glass substrates under 760-Torr oxygen for 10 min over the same temperature intervals as Sangaletti et al.⁹ Geurts et al.¹² found dominant peaks at 126 cm⁻¹ and 171 cm⁻¹. The first peak agrees with the high-energy Raman peak in metallic β -Sn.¹³ This is consistent with the X-ray data, which confirms the presence of β -Sn in the partially oxidized samples. Combined, these results indicate that the 145 cm⁻¹ and the 171 cm⁻¹ peaks do not correspond to the same stoichiometric phase. Hence we conclude that Sangaletti's samples and our nanobelt samples contain at least two partially oxidized stoichiometric phases, which could be Sn₂O₃/Sn₃O₄ or some other unknown phase.

We next focus our discussion on the origin of weak peaks in the 20 \times spectra in Figure 1. For clarity, in Figure 2, we reproduce the spectrum of a SnO₂ sample collected with 488-nm excitation along with a phonon density of states (DOS) calculation by K. Parlinski, using PHONON software.¹⁴ This author recently published the first *ab initio* calculation of phonons in SnO₂,¹⁴ and his calculated frequencies are in excellent agreement with the known IR and Raman spectra of SnO₂. In the presence

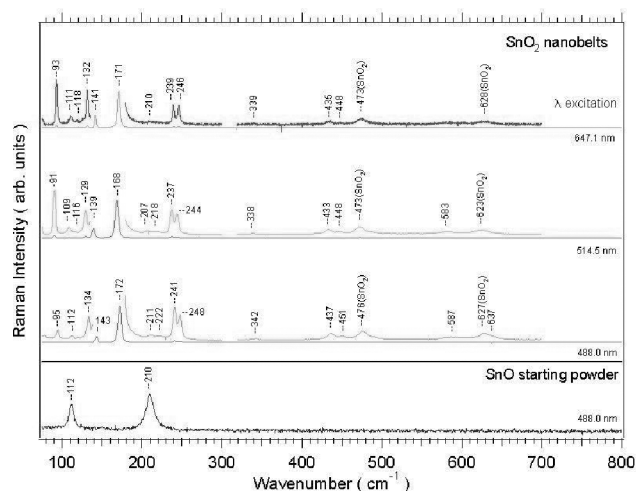


Fig. 1. Raman spectra collected from as-prepared SnO₂ nanobelt (top) and starting powder (bottom) samples. The label $\lambda_{\text{excitation}}$ refers to the laser excitation wavelength. All magnified spectra are 20 \times .

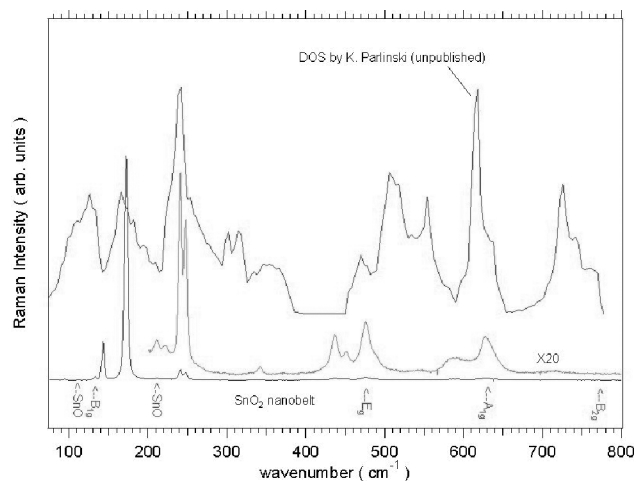


Fig. 2. Comparison of a 488-nm SnO₂ nanobelt spectrum with the calculated density of states (see text).

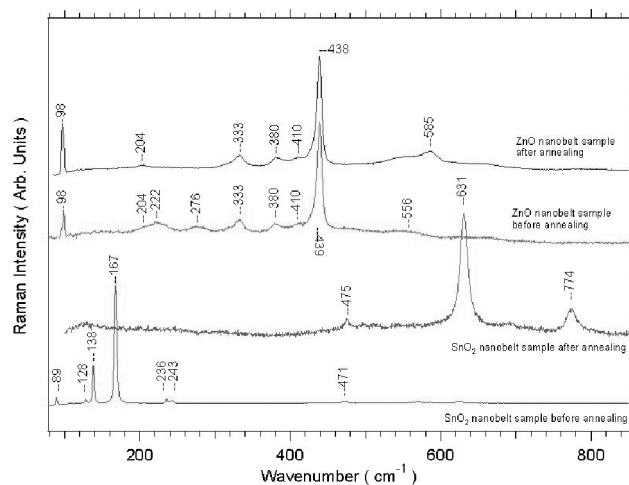


Fig. 4. Comparison of Raman data taken from as-prepared and postannealed nanobelt samples.

4. CONCLUSIONS

No quantum size effects on the phonon structure of nanobelt samples were observed in this study. Room-temperature Raman data of as-prepared nanobelt samples exhibited peaks that corresponded to those expected in oxygen-deficient semiconducting SnO_2 and ZnO . Raman peaks corresponding to bulk SnO_2 and ZnO were observed in nanobelt samples after postannealing in oxygen for 1 h at 900°C .

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